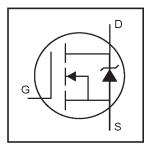
International Rectifier

IRFZ44ESPbF IRFZ44ELPbF

HEXFET® Power MOSFET

- Advanced Process Technology
- Surface Mount (IRFZ44ES)
- Low-profile through-hole (IRFZ44EL)
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

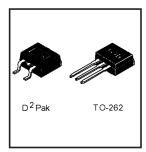


$V_{DSS} = 60V$ $R_{DS(on)} = 0.023\Omega$ $I_D = 48A$

Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The D²Pak is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The D²Pak is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application. The through-hole version (IRFZ44EL) is available for low-profile applications.



Absolute Maximum Ratings

| | Parameter | Max. | Units |
|---|--|------------------------|-------|
| I _D @ T _C = 25°C | Continuous Drain Current, V _{GS} @ 10V® | 48 | |
| I _D @ T _C = 100°C | Continuous Drain Current, V _{GS} @ 10V® | 34 | A |
| I _{DM} | Pulsed Drain Current ①⑤ | 192 |] |
| $P_D @ T_C = 25 ° C$ | Power Dissipation | 110 | W |
| | Linear Derating Factor | 0.71 | W/°C |
| V_{GS} | Gate-to-Source Voltage | ± 20 | V |
| E _{AS} | Single Pulse Avalanche Energy②⑤ | 220 | mJ |
| I _{AR} | Avalanche Current① | 29 | А |
| E _{AR} | Repetitive Avalanche Energy① | 11 | mJ |
| dv/dt | Peak Diode Recovery dv/dt ③⑤ | 5.0 | V/ns |
| T _J | Operating Junction and | -55 to + 175 | |
| T _{STG} | Storage Temperature Range | | °C |
| | Soldering Temperature, for 10 seconds | 300 (1.6mm from case) |] |
| | Mounting torque, 6-32 or M3 srew | 10 lbf•in (1.1N•m) | |

Thermal Resistance

| | Parameter | Тур. | Max. | Units |
|-----------------|-------------------------------------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case | | 1.4 | |
| Recs | Case-to-Sink, Flat, Greased Surface | 0.50 | — | °C/W |
| $R_{\theta JA}$ | Junction-to-Ambient | | 62 | |

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Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

| | Parameter | Min. | Тур. | Max. | Units | Conditions |
|--|--------------------------------------|------|-------|-------|-------|--|
| V _{(BR)DSS} | Drain-to-Source Breakdown Voltage | 60 | | | V | $V_{GS} = 0V, I_D = 250\mu A$ |
| DV _{(BR)DSS} /DT _J | Breakdown Voltage Temp. Coefficient | | 0.063 | | V/°C | Reference to 25°C, I _D = 1mA ^⑤ |
| R _{DS(on)} | Static Drain-to-Source On-Resistance | | | 0.023 | Ω | V _{GS} = 10V, I _D = 29A ④ |
| V _{GS(th)} | Gate Threshold Voltage | 2.0 | | 4.0 | V | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$ |
| 9 _{fs} | Forward Transconductance | 15 | _ | | S | V _{DS} = 30V, I _D = 29A ^⑤ |
| | Drain-to-Source Leakage Current | _ | _ | 25 | μΑ . | V _{DS} = 60V, V _{GS} = 0V |
| IDSS | | | | 250 | | $V_{DS} = 48V, V_{GS} = 0V, T_{J} = 150$ °C |
| | Gate-to-Source Forward Leakage | | | 100 | nA | V _{GS} = 20V |
| IGSS | Gate-to-Source Reverse Leakage | | | -100 | IIA | $V_{GS} = -20V$ |
| Qg | Total Gate Charge | | | 60 | | I _D = 29A |
| Q _{gs} | Gate-to-Source Charge | | | 13 | nC | $V_{DS} = 48V$ |
| Q _{gd} | Gate-to-Drain ("Miller") Charge | | | 23 | | V _{GS} = 10V, See Fig. 6 and 13 ⊕ ⑤ |
| t _{d(on)} | Turn-On Delay Time | | 12 | | | V _{DD} = 30V |
| t _r | Rise Time | | 60 | _ | | $I_D = 29A$ |
| t _{d(off)} | Turn-Off Delay Time | | 70 | | ns | $R_G = 15\Omega$ |
| t _f | Fall Time | | 70 | | | R _D = 1.1Ω, See Fig. 10 ⊕ ⑤ |
| La | Internal Source Inductance | | 7.5 | | nН | Between lead, |
| L _S | internal Source inductance | | 7.5 | | '''' | and center of die contact |
| C _{iss} | Input Capacitance | | 1360 | | | V _{GS} = 0V |
| Coss | Output Capacitance | _ | 420 | _ | рF | $V_{DS} = 25V$ |
| C _{rss} | Reverse Transfer Capacitance | | 160 | | i l | f = 1.0MHz, See Fig. 5® |

Source-Drain Ratings and Characteristics

| | Parameter | Min. | Тур. | Max. | Units | Conditions | | | | |
|-----------------|---------------------------|--|-------|------|-------|---|-----|-----|-----|------------------|
| Is | Continuous Source Current | | | 48 | | MOSFET symbol | | | | |
| | (Body Diode) | - | | 40 | A | showing the | | | | |
| I _{SM} | Pulsed Source Current | | — 192 | | 400 | 400 | 400 | 400 | 1 ^ | integral reverse |
| | (Body Diode)① | | | 192 | | p-n junction diode. | | | | |
| V _{SD} | Diode Forward Voltage | I — | — | 1.3 | ٧ | $T_J = 25$ °C, $I_S = 29$ A, $V_{GS} = 0$ V ④ | | | | |
| t _{rr} | Reverse Recovery Time | T | 69 | 104 | ns | $T_J = 25$ °C, $I_F = 29A$ | | | | |
| Q _{rr} | Reverse Recovery Charge | 1 — | 177 | 266 | nC | di/dt = 100A/µs ④ | | | | |
| t _{on} | Forward Turn-On Time | Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D) | | | | | | | | |

Notes:

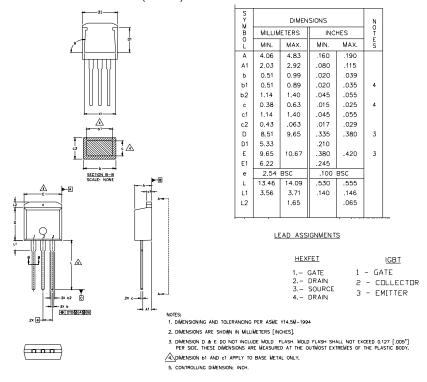
- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- Starting T_J = 25°C, L = 520μH R_G = 25Ω, I_{AS} = 29A. (See Figure 12)
- $\label{eq:loss} \begin{array}{l} \text{ } \\ \text{ }$
- 4 Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.
- ⑤ Uses IRFZ44E data and test conditions

^{**} When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended soldering techniques refer to application note #AN-994.

IRFZ44ES/LPbF

TO-262 Package Outline

Dimensions are shown in millimeters (inches)



TO-262 Part Marking Information

